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| Notice of References Cited | Application/Control No. | Applicant(s)/Patent Under Reexamination | |
| | 10/032,597 | LANGHAMMER, MARTIN | |
| | Examiner | Art Unit | Page 1 of 1 |
| | Sudhanshu C. Pathak | 2634 | |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | A | US-5,432,821 | 07-1995 | Polydoros et al. | 375/340 |
| | B | US-5,940,416 | 08-1999 | Nishiya et al. | 714/795 |
| | C | US-3,789,360 | 01-1974 | Clark et al. | 714/792 |
| | D | US-5,946,361 | 08-1999 | Araki et al. | 375/341 |
| | E | US-6,507,921 | 01-2003 | Buser et al. | 714/45 |
| | F | US-5,815,515 | 09-1998 | Dabiri, Dariush | 714/795 |
| | G | US-6,788,750 | 09-2004 | Reuven et al. | 375/341 |
| | H | US-6,690,750 | 02-2004 | Hocevar et al. | 375/341 |
| | I | US-6,877,132 | 04-2005 | De et al. | 714/795 |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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